

Advanced Thermal and Embedded Solutions for Laminate Substrate Designs

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Abstract

As demand for high-powered solutions and smaller package footprints continues to grow, it drives the need for continued advancement of laminate based substrate technologies. Besides shrinking the conventional SMT component and utilizing high thermally conductive epoxies, advancing the laminate substrate is the next step to increase functional integration and reduce package footprint. By embedding active and passive components as well as utilizing alternative fabrication methods we can balance increasing functional density while mitigating thermal challenges. This poster will review and compare various thermal solutions including standard vias, slot vias, and embedded heat slugs from both a fabrication and thermal modeling point of view.

Packaging Solutions

The demand for higher power multi-chip modules in smaller laminate package footprints has necessitated the development of alternative thermal solutions from conventional standard via construction. There are now options available to incorporate slot vias, embedded thermal slugs and cavities to facilitate improved heat transfer. Additionally, there are solutions for packaging embedded active and passive components to further reduce laminate package footprints.

Thermal

- Standard Vias (conventional)
 - Various diameters and pitch/array sizes
 - Conductive, non-conductive, or solid copper depending on aspect ratio
 - Lowest cost for fabrication



- Solid copper elongated vias
- Increased surface area for thermal dissipation
- Potential for RF shielding
- Low Medium cost for fabrication

Thermal Slugs

- Embedded
- Material options include Cu, AIN, CuW, CuMo, and CuMoCu
- Slug needs to be matched in terms of CTE to laminate
- Higher cost for fabrication (Improved thermal performance)

Cavity Laminate

- Die mounted directly to cavity base
- Cavity is typically lasered or mechanically routed
- Shorter RF bond wires
- Higher cost for fabrication
- Improved thermal and RF performance

Embedded Components

• Passive and Active

- Die or component placed into internal layers
- Reduced package footprint
- Improved signal performance
- Higher cost for fabrication/ Lower cost assembly









Fig.4: Die in Cavity





Model Parameters

- Package
 - 5 x 5 mm LGA
 - 1/2 oz starting copper weight top and bottom
 - Die attached to laminate surface or cavity using silver epoxy
 - Thermal Conductivity: 24 W/(m-K)
 - 80um outer diameter Vias: Cu filled (conventional & slot vias)
 - Via array size 12 x 8, 180um pitch (conventional vias)
 - Via array size 12 x 1, 180um pitch (slot vias)
 - Cu coin is the same length and width as the die
 - Cavity had die mounted on bottom metal with extra plating
- Device Performance
 - 1 Watt power dissipation
 - Running at CW

Package Thermal Modeling: Thermal Cut Planes



Thermal Package Model Results



Fig. 9: Package Configuration Thermal Results

- package construction methods.
- Slot Vias can be utilized in applications where there is a necessity for additional power dissipation (from conventional vias) allowing an increase in surface area for heat transfer with variable size, pitch, and pattern flexibility.
- Embedded Thermal slugs increase the surface area greater than conventional and slot vias and maximizes heat transfer. Various thermal slug material options are available but CTE match to the laminate also needs to be considered.
- Cavity laminates maximize surface area for heat transfer and minimize the thermal length (medium) for improved heat transfer rate.



Package Level Thermal Modeling



0.84		Z-Structure	R _{jc,bottom} (°C/W)	(R _{structure}) / (R _{cavity})
		Plated vias	2.32	276%
		Solid vias	2.12	252%
		Slot vias	1.36	162%
		Coin	1.10	131%
Cavity		Cavity	0.84	100%

Table 1: Package Configuration Thermal Results (1W)

Summary

Advanced thermal packaging solutions can provide significant thermal performance improvements over conventional